

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 211559US2SRDDIV		SERIAL NO. 09/920,936	
<div style="position: relative; height: 100px;"> <div style="position: absolute; top: 0; left: 0; width: 100%; height: 100%; border: 1px solid black; border-radius: 50%; text-align: center; color: black; font-weight: bold; font-size: 1.2em;"> OIP E  JUN 28 2005  PATENT &amp; TRADEMARK OFFICE </div> </div>				APPLICANT Toshiaki WATANABE, et al.			
				FILING DATE August 3, 2001		GROUP 2663 2667	
U.S. PATENT DOCUMENTS							
INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
AB	AA	5,162,923	11/10/92	T. YOSHIDA, et al.			
	AB						
	AC						
	AD						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
AB	AL	04-239839	08/27/92	JAPAN (with English Abstract)			X
AB	AM	04-245833	1992	JAPAN (submitting corr. EP 0 497 452 only)			
	AN	0 497 452	08/05/92	EUROPE—			
AB	AO	01-213067	1989	JAPAN (submitting corr. US 5,162,923 only)			
AB	AP	07-508380	1995	JAPAN (submitting corr. WO 94/00952 only)			
AB	AQ	WO 94/00952	01/06/94	WIPO			
AB	AR	07-162801	06/23/95	JAPAN (with English Abstract)			X
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
AB	AS	Patent Abstracts of Japan, JP 08-162979, June 21, 1996					
AB	AT	Patent Abstracts of Japan, JP 57-115043, July 17, 1982					
AB	AU	Patent Abstracts of Japan, JP 02-062176, March 2, 1990					
AB	AV	Patent Abstracts of Japan, JP 07-143480, June 2, 1995					
AB	AW	Patent Abstracts of Japan, JP 02-206292, August 16, 1990					
AB	AX	Patent Abstracts of Japan, JP 06-086251, March 25, 1994					
AB	AY	Patent Abstracts of Japan, JP 06-215492, August 5, 1994					
AB	AZ	Patent Abstracts of Japan, JP 06-205384, July 22, 1994					
Examiner ALEXANDER BOAKYE				Date Considered 9/20/05			
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.  
211559US-2SRD-DIVSERIAL NO.  
New Div. Application

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Toshiaki WATANABE, et al.

FILING DATE

Herewith

GROUP 2667  
To be assigned971 U.S. PTO  
09/20/05

08/03/01

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
AB	AA	5,430,738	07/04/95	Y. TSUDA			
AB	AB	5,289,276	02/22/94	R.J. SIRACUSA, et al.			
AB	AC	5,483,287	01/09/96	R.J. SIRACUSA			
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO	
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	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

Examiner

ALEXANDER BOAKYE

Date Considered

9/20/05

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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Toshiaki WATANABE, et al.			
				FILING DATE Herewith		GROUP 2669 To be assigned	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
AB	AO	2,037,527	09/06/91	CANADA			
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	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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J=911 J.S. PTD  
 09/20/05  
 09/03/01